

APPLICATION DATA SHEET

Electronic Version v14

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Title of Invention	Wafer-Level Tester With Magnet To Test Latching Micro-Magnetic Switches
Application Type: regular, utility Attorney Docket Number: 2040.0250001/DJF/JSW	
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Continuing Data: This is a Non-Provisional of US application number 60/462,312, filed 2003-04-14.	
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as our attorney(s) or agent(s) to prosecute the application identified above, and to transact all business in the United States Patent and Trademark Office connected therewith.